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BUK7510-55AL

N-channel TrenchMOS standard level FET

Rev. 03 — 4 August 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Q101 compliant
- Suitable for thermally demanding environments due to 175 °C rating
- Suitable for use in control systems due to stable operation in linear mode

1.3 Applications

- 12 V and 24 V loads
- Automotive systems

- DC motor control
- Repetitive clamped inductive switching

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	55	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>	[1]	-	-	75	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	300	W
Avalanch	ne ruggedness						
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 75 A; $V_{sup} \le$ 55 V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	-	1.1	J
Dynamic	characteristics						
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V; } I_D = 25 \text{ A;}$ $V_{DS} = 44 \text{ V; } T_j = 25 \text{ °C;}$ see Figure 15		-	50	-	nC
Static ch	aracteristics						
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \underline{\text{Figure 12}};$ $\text{see } \underline{\text{Figure 13}}$		-	8.5	10	mΩ

^[1] Continuous current is limited by package.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	D
3	S	source		G (F)
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT78 (TO-220AB;SC-46)	

3. Ordering information

Table 3. Ordering information

Type number	Package						
	Name	Description	Version				
BUK7510-55AL	TO-220AB; SC-46	Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78				

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	55	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	55	V
V_{GS}	gate-source voltage			-20	20	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	[1][2]	-	122	Α
		T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	[3]	-	75	Α
		T _{mb} = 100 °C; V _{GS} = 10 V; see <u>Figure 1</u>	[3]	-	75	Α
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \mu s$; pulsed; see <u>Figure 3</u>		-	490	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	300	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dra	ain diode					
Is	source current	$T_{mb} = 25 ^{\circ}C;$	[1][2]	-	122	Α
		$T_{mb} = 25 ^{\circ}C;$	[3]	-	75	Α
I_{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	490	Α
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 75 A; V_{sup} ≤ 55 V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	1.1	J
E _{DS(AL)R}	repetitive drain-source avalanche energy	see Figure 4	[4][5] [6]	-	-	J

^[1] Current is limited by power dissipation chip rating.

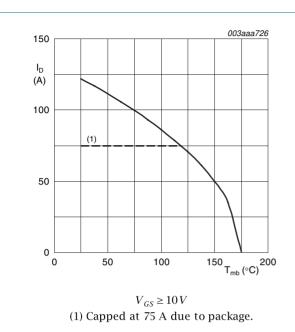
^[2] Refer to document 9397 750 12572 for further information.

^[3] Continuous current is limited by package.

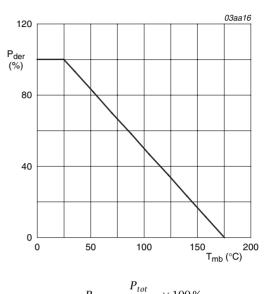
^[4] Single-shot avalanche rating limited by maximum junction temperature of 175 °C.

^[5] Repetitive avalanche rating limited by average junction temperature of 170 °C.

^[6] Refer to AN10273 for further information.



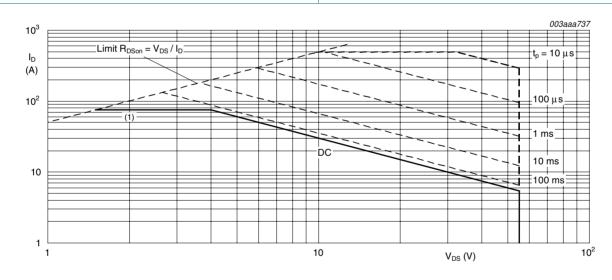
Continuous drain current as a function of mounting base temperature



 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$

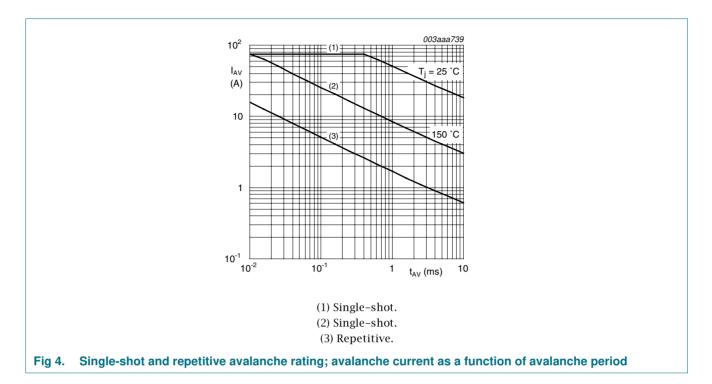
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Normalized total power dissipation as a Fig 2. function of mounting base temperature



 $T_{mb} = 25 \,^{\circ}C; I_{DM}$ is single pulse (1) Capped at 75 A due to package.

Safe operating area; continuous and peak drain currents as a function of drain-source voltage Fig 3.



5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 5	-	0.25	0.5	K/W

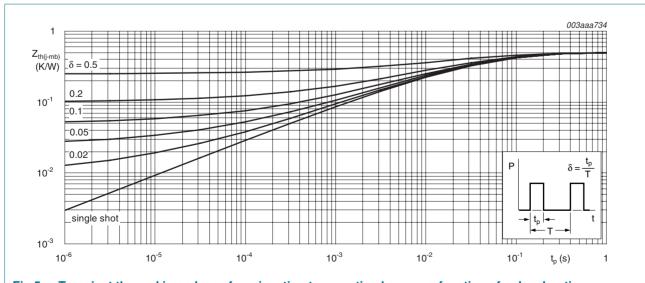


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$	50	-	-	V
breakdown voltage		$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$	55	-	-	V
$V_{GS(th)} \\$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 10</u> ; see <u>Figure 11</u>	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = -55$ °C; see <u>Figure 10</u> ; see <u>Figure 11</u>	-	-	4.4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see Figure 10; see Figure 11	1	-	-	V
loss	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
l _{GSS}	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = +20 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -20 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	2	100	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 12; see Figure 13	-	-	20	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 12; see Figure 13	-	8.5	10	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}$; $V_{DS} = 44 \text{ V}$; $V_{GS} = 10 \text{ V}$;	-	124	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 15</u>	-	22	-	nC
Q_{GD}	gate-drain charge		-	50	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 25 \text{ A}$; $V_{DS} = 44 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 15	-	5	-	V
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	4710	6280	pF
Coss	output capacitance	T _j = 25 °C; see <u>Figure 16</u>	-	980	1180	pF
C _{rss}	reverse transfer capacitance		-	560	770	pF
d(on)	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$	-	33	-	ns
r	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	117	-	ns
d(off)	turn-off delay time		-	132	-	ns
t _f	fall time		-	95	-	ns
L _D	internal drain inductance	from contact screw on package to centre of die; T _i = 25 °C	-	3.5	-	nΗ
		from drain lead 6mm from package to centre of die; T _j = 25 °C	-	4.5	-	Н
-S	internal source inductance	from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-d	rain diode					
V _{SD}	source-drain voltage	$I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 14	-	0.85	1.2	V
	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	73	-	ns
rr	,					

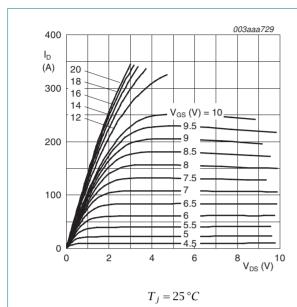
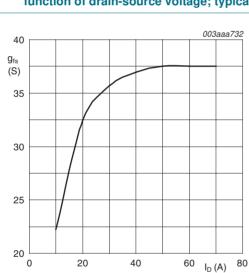


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_{j} = 25 \,{}^{\circ}C; V_{DS} = 25 \, V$

Fig 8. Forward transconductance as a function of drain current; typical values

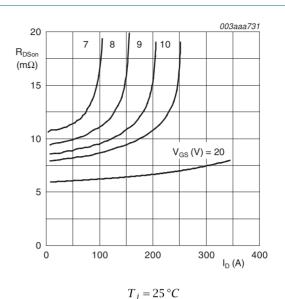


Fig 7. Drain-source on-state resistance as a function of drain current; typical values

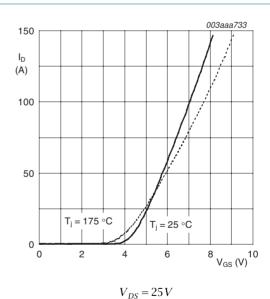
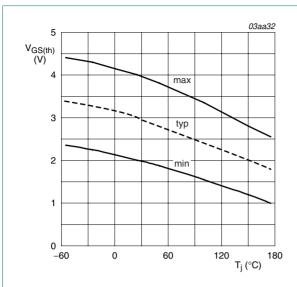
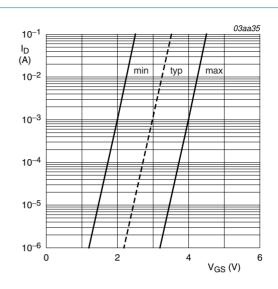


Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values



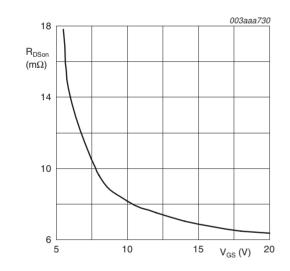
 $I_D = 1 \, mA; V_{DS} = V_{GS}$

Fig 10. Gate-source threshold voltage as a function of junction temperature



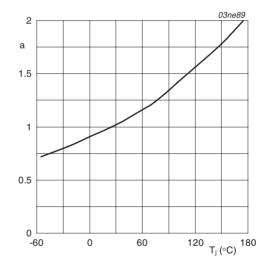
$$T_j = 25$$
 °C; $V_{DS} = 5V$

Fig 11. Sub-threshold drain current as a function of gate-source voltage



 $T_{j} = 25 \,^{\circ}C; I_{D} = 25A$

Fig 12. Drain-source on-state resistance as a function of gate-source voltage; typical values



$$a = \frac{R_{DSon}}{R_{DSon(2.5^{\circ}C)}}$$

Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

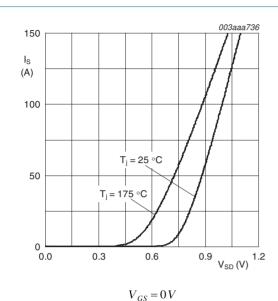
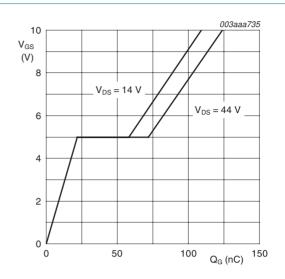
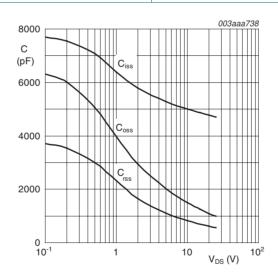


Fig 14. Source current as a function of source-drain voltage; typical values



$$T_i = 25 \,^{\circ}C; I_D = 25A$$

Fig 15. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

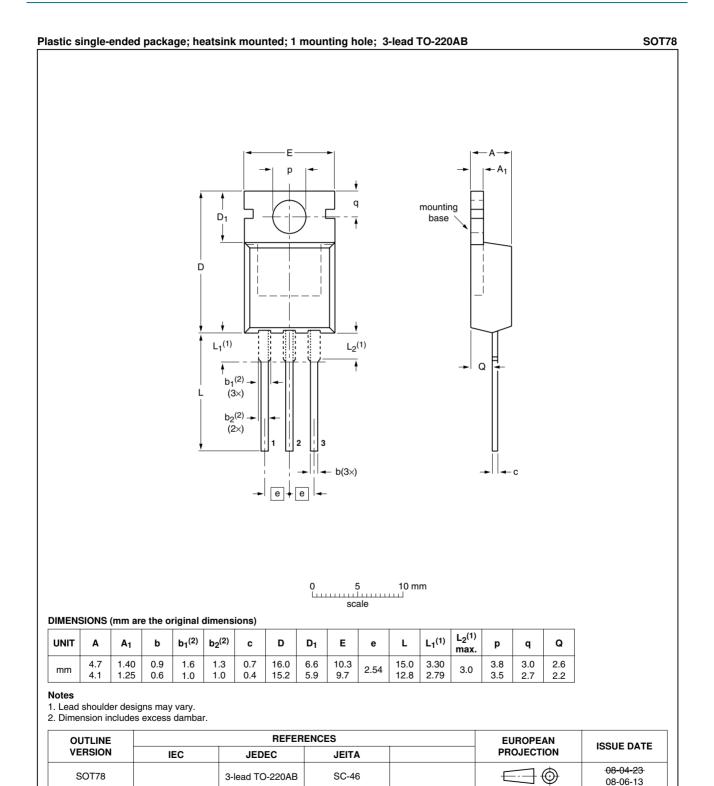


Fig 17. Package outline SOT78 (TO-220AB)



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N-channel TrenchMOS standard level FET

Revision history

Table 7. **Revision history**

Product data sheet

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7510-55AL_3	20090804	Product data sheet	-	BUK7510-55AL_2
Modifications:	Package or	utline updated.		
BUK7510-55AL_2	20080103	Product data sheet	-	BUK75_7610_55AL_1
BUK75_7610_55AL_1	20050331	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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